WEST Search History

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DATE: Friday, July 29, 2005

Hide?	Set Name	Query	Hit Count
		DB=PGPB,USPT,USOC; PLUR=YES; OP=ADJ	
☐	L11	l4 and l10	8
☐	L10	134/6,32,33;438/690;451/28.ccls.	4907
		DB=USPT; PLUR=YES; OP=ADJ	
☐	L9	l8 and ($5scratch$3 or rough$7)	1
☐	L8	US-4731757-$.DID. OR US-4780848-$.DID. OR US-5569617-$.DID. OR US-5704987-$.DID. OR US-5956267-$.DID. OR US-6048739-$.DID. OR US-6413869-$.DID. OR US-6500676-$.DID.	8
		DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI; PLUR=YES; OP=ADJ	
☐	L7	L4 with (without or no)with abrasive	8
☐	L6	L4 with (without adj10 abrasive)	3
☐	L5	L4 with (without adj7 abrasive)	3
☐	L4	(wafer or substrate or semiconductor) with($5scratch$3 or rough$7) with (polish$3 adj5 (water or liquid))	188
☐	L3	honeywell and (($5scratch$3 or rough$7) with (polish$3 adj5 (slurry or abrasive)))	15
☐	L2	honeywell and (($5scratch$3 or rough$7) with (polish$3 without (slurry or abrasive)))	0
☐	L1	honeywell and (($5scratch$3 or rough$7) with polish$3 not (slurry or abrasive))	49

END OF SEARCH HISTORY